



OFGS File No: P/29-1642

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

New York, New York

ITO, Munehiro

Date: May 26, 2005

Serial No.:

10/723,278

Group Art Unit: 2813

Date Filed:

November 24, 2003

For:

METHOD FOR TESTING SEMICONDUCTOR MEMORY DEVICE AND TEST

CIRCUIT FOR SEMICONDUCTOR MEMORY DEVICE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

STATUS INQUIRY LETTER

Sir:

We filed the above application with the U. S. Patent and Trademark Office on November 24, 2003.

As of this date, we have not received a first Office Action from the Patent Office. Kindly advise us of the status of this application.

Respectfully Submitted,

Attorney: Max Moskpwitz

OSTROLENK, FABER, GERB & SOFFEN

1180 Avenue of the Americas New York, New York 10036-8403

(212) 382-0700